## Application/Control No. Applicant(s)/Patent Under Reexamination 10/535,582 KIMURA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1657 David M. Naff **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 435/6 Α US-7,037,649 B2 05-2006 Kimura et al. US-В US-С US-D US-Ε US-F US-G US-Н US-1 US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY N 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) W

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